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Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	48MHz
Connectivity	I ² C, LINbus, SCI, SPI, UART/USART, USB
Peripherals	DMA, POR, PWM, WDT
Number of I/O	51
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	1.62V ~ 3.63V
Data Converters	A/D 20x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-TQFP
Supplier Device Package	64-TQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/atsaml21j16b-ant

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18.8.6. Low Power Clock Division

Name:LPDIVOffset:0x05Reset:0x01Property:PAC Write-Protection

Bit	7	6	5	4	3	2	1	0
				LPDI	V[7:0]			
Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W
Reset	0	0	0	0	0	0	0	1

Bits 7:0 – LPDIV[7:0]: Low-Power Clock Division Factor

These bits define the division ratio of the main clock prescaler (2ⁿ) related to the Low Power clock domain. To ensure correct operation, frequencies must be selected so that $F_{CPU} \ge F_{LP} \ge F_{BUP}$ (i.e. BUPDIV \ge LPDIV \ge CPUDIV). Also, frequencies must never exceed the specified maximum frequency for each clock domain.

Value	Name	Description
0x01	DIV1	Divide by 1
0x02	DIV2	Divide by 2
0x04	DIV4	Divide by 4
0x08	DIV8	Divide by 8
0x10	DIV16	Divide by 16
0x20	DIV32	Divide by 32
0x40	DIV64	Divide by 64
0x80	DIV128	Divide by 128
others	-	Reserved



18.8.9. APBB Mask

Name:APBBMASKOffset:0x18Reset:0x00000017Property:PAC Write-Protection

Bit	31	30	29	28	27	26	25	24
[Reserved[28:21]							
Access	R	R	R	R	R	R	R	R
Reset	0	0	0	0	0	0	0	0
Bit	23	22	21	20	19	18	17	16
				Reserve	ed[20:13]			
Access	R	R	R	R	R	R	R	R
Reset	0	0	0	0	0	0	0	0
Bit	15	14	13	12	11	10	9	8
	Reserved[12:5]							
Access	R	R	R	R	R	R	R	R
Reset	0	0	0	0	0	0	0	0
Bit	7	6	5	4	3	2	1	0
[Reserved[4:0]			NVMCTRL	DSU	USB
Access	R	R	R	R	R	R/W	R/W	R/W
Reset	0	0	0	1	0	1	1	1

Bits 31:3 – Reserved[28:0]: Reserved bits

Reserved bits are unused and reserved for future use. For compatibility with future devices, always write reserved bits to their reset value. If no reset value is given, write 0.

Bit 2 – NVMCTRL: NVMCTRL APBB Clock Enable

Value	Description
0	The APBB clock for the NVMCTRL is stopped
1	The APBB clock for the NVMCTRL is enabled

Bit 1 – DSU: DSU APBB Clock Enable

Value	Description
0	The APBB clock for the DSU is stopped
1	The APBB clock for the DSU is enabled

Bit 0 – USB: USB APBB Clock Enable

Value	Description
0	The APBB clock for the USB is stopped
1	The APBB clock for the USB is enabled

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23.6.2.2. Enabling, Disabling, and Resetting

The voltage reference output is enabled/disabled by setting/clearing the Voltage Reference Output Enable bit in the Voltage Reference register (VREF.VREFOE).

The temperature sensor is enabled/disabled by setting/clearing the Temperature Sensor Enable bit in the Voltage Reference register (VREF.TSEN).

Note: When VREF.ONDEMAND=0, it is not recommended to enable both voltage reference output and temperature sensor at the same time - only the voltage reference output will be present at both ADC inputs.

23.6.2.3. Selecting a Voltage Reference

The Voltage Reference Selection bit field in the VREF register (VREF.SEL) selects the voltage of INTREF to be applied to analog modules, e.g. the ADC.

23.6.2.4. Sleep Mode Operation

The Voltage Reference output and the Temperature Sensor output behavior during sleep mode can be configured using the Run in Standby bit and the On Demand bit in the Voltage Reference register (VREF.RUNSTDBY, VREF.ONDEMAND), see the following table:

VREF.ONDEMAND	VREF.RUNSTDBY	Voltage Reference Sleep behavior
-	-	Disable
0	0	Always run in all sleep modes except standby sleep mode
0	1	Always run in all sleep modes including standby sleep mode
1	0	Only run if requested by the ADC, in all sleep modes <i>except</i> standby sleep mode
1	1	Only run if requested by the ADC, in all sleep modes <i>including</i> standby sleep mode

Table 23-2. VREF Sleep Mode Operation

23.6.3. Battery Backup Power Switch

23.6.3.1. Initialization

The Battery Backup Power Switch (BBPS) is disabled at power-up, and the backup domain is supplied by main power.

23.6.3.2. Forced Battery Backup Power Switch

The Backup domain is always supplied by the VBAT supply pin when the Configuration bit field in the Battery Backup Power Switch Control register (BBPS.CONF) is written to 0x2 (FORCED).

23.6.3.3. Automatic Battery Backup Power Switch

The supply of the backup domain can be switched automatically to VBAT supply pin by the Automatic Power Switch or by using the BOD33.

The supply of the backup domain can be switched automatically to VDD supply pin either by the Automatic Power Switch or the Main Power Pin when VDD and VDDCORE are restored.

Automatic Power Switch (APWS)

When the Configuration bit field in the Battery Backup Power Switch register (BBPS.CONF) is selecting the APWS, the Automatic Power Switch will function as Battery Backup Power Switch.

The Automatic Power switch allows to switch the supply of the backup domain from VDD to VBAT power and vice-versa.



Table 24-1. WDT Operating Modes

CTRLA.ENABLE	CTRLA.WEN	Interrupt Enable	Mode
0	x	x	Stopped
1	0	0	Normal mode
1	0	1	Normal mode with Early Warning interrupt
1	1	0	Window mode
1	1	1	Window mode with Early Warning interrupt

24.6.2. Basic Operation

24.6.2.1. Initialization

The following bits are enable-protected, meaning that they can only be written when the WDT is disabled (CTRLA.ENABLE=0):

- Control A register (CTRLA), except the Enable bit (CTRLA.ENABLE)
- Configuration register (CONFIG)
- Early Warning Interrupt Control register (EWCTRL)

Enable-protected bits in the CTRLA register can be written at the same time as CTRLA.ENABLE is written to '1', but not at the same time as CTRLA.ENABLE is written to '0'.

The WDT can be configured only while the WDT is disabled. The WDT is configured by defining the required Time-Out Period bits in the Configuration register (CONFIG.PER). If Window mode operation is desired, the Window Enable bit in the Control A register must be set (CTRLA.WEN=1) and the Window Period bits in the Configuration register (CONFIG.WINDOW) must be defined.

Enable-protection is denoted by the "Enable-Protected" property in the register description.

24.6.2.2. Configurable Reset Values

After a Power-on Reset, some registers will be loaded with initial values from the NVM User Row.

This includes the following bits and bit groups:

- Enable bit in the Control A register, CTRLA.ENABLE
- Always-On bit in the Control A register, CTRLA.ALWAYSON
- Watchdog Timer Windows Mode Enable bit in the Control A register, CTRLA.WEN
- Watchdog Timer Windows Mode Time-Out Period bits in the Configuration register, CONFIG.WINDOW
- Time-Out Period bits in the Configuration register, CONFIG.PER
- Early Warning Interrupt Time Offset bits in the Early Warning Interrupt Control register, EWCTRL.EWOFFSET

Related Links

NVM User Row Mapping on page 47

24.6.2.3. Enabling, Disabling, and Resetting

The WDT is enabled by writing a '1' to the Enable bit in the Control A register (CTRLA.ENABLE). The WDT is disabled by writing a '0' to CTRLA.ENABLE.

The WDT can be disabled only if the Always-On bit in the Control A register (CTRLA.ALWAYSON) is '0'.



Value	Description
0	The WDT is disabled.
1	The WDT is enabled.



Bits 5:0 – SECOND[5:0]: Second 0 – 59



28.8.2. Control B

Name:CTRLBOffset:0x04Reset:0x0000080Property:PAC Write-Protection

Bit	31	30	29	28	27	26	25	24
Access								
Reset								
Bit	23	22	21	20	19	18	17	16
						CACHEDIS	READM	ODE[1:0]
Access		•	•		•	R/W	R/W	R/W
Reset						0	0	0
Bit	15	14	13	12	11	10	9	8
							SLEEPF	PRM[1:0]
Access							R/W	R/W
Reset							0	0
Bit	7	6	5	4	3	2	1	0
	MANW				RWS	6[3:0]		
Access	R/W			R/W	R/W	R/W	R/W	
Reset	1			0	0	0	0	

Bit 18 – CACHEDIS: Cache Disable

This bit is used to disable the cache.

Value	Description
0	The cache is enabled
1	The cache is disabled

Bits 17:16 - READMODE[1:0]: NVMCTRL Read Mode

Value	Name	Description
0x0	NO_MISS_PENALTY	The NVM Controller (cache system) does not insert wait states on a cache miss. Gives the best system performance.
0x1	LOW_POWER	Reduces power consumption of the cache system, but inserts a wait state each time there is a cache miss. This mode may not be relevant if CPU performance is required, as the application will be stalled and may lead to increased run time.

Figure 29-5. I/O Configuration - Input with Pull



Note: When pull is enabled, the pull value is defined by the OUT value.

29.6.3.3. Totem-Pole Output

When configured for totem-pole (push-pull) output, the pin is driven low or high according to the corresponding bit setting in the OUT register. In this configuration there is no current limitation for sink or source other than what the pin is capable of. If the pin is configured for input, the pin will float if no external pull is connected.

Note: Enabling the output driver will automatically disable pull.

Figure 29-6. I/O Configuration - Totem-Pole Output with Disabled Input



Figure 29-7. I/O Configuration - Totem-Pole Output with Enabled Input



Figure 29-8. I/O Configuration - Output with Pull





USERm	User Multiplexer	Description	Path Type
m = 42	Reserved	-	-
m = 43	MTB START	Tracing start	Asynchronous, synchronous, and resynchronized paths
m = 44	MTB STOP	Tracing stop	Asynchronous, synchronous, and resynchronized paths
others	Reserved	-	-







A counter wraparound can occur in any operation mode when up-counting without buffering, see Figure 36-10. COUNT and TOP are continuously compared, so when a new value that is lower than the current COUNT is written to TOP, COUNT will wrap before a compare match.





When double buffering is used, the buffer can be written at any time and the counter will still maintain correct operation. The period register is always updated on the update condition, as shown in Figure 36-13. This prevents wraparound and the generation of odd waveforms.

Figure 36-13. Changing the Period Using Buffering



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Value	Name	Description
0x0	DISABLE	Halt action disabled
0x1	HW	Hardware halt action
0x2	SW	Software halt action
0x3	NR	Non-recoverable fault

Bit 7 – RESTART: Recoverable Fault n Restart

Setting this bit enables restart action for Fault n.

Value	Description
0	Fault n restart action is disabled.
1	Fault n restart action is enabled.

Bits 6:5 – BLANK[1:0]: Recoverable Fault n Blanking Operation

These bits, select the blanking start point for recoverable Fault n.

Value	Name	Description
0x0	START	Blanking applied from start of the Ramp period
0x1	RISE	Blanking applied from rising edge of the waveform output
0x2	FALL	Blanking applied from falling edge of the waveform output
0x3	BOTH	Blanking applied from each toggle of the waveform output

Bit 4 – QUAL: Recoverable Fault n Qualification

Setting this bit enables the recoverable Fault n input qualification.

Value	Description
0	The recoverable Fault n input is not disabled on CMPx value condition.
1	The recoverable Fault n input is disabled when output signal is at inactive level (CMPx == 0).

Bit 3 – KEEP: Recoverable Fault n Keep

Setting this bit enables the Fault n keep action.

Value	Description
0	The Fault n state is released as soon as the recoverable Fault n is released.
1	The Fault n state is released at the end of TCC cycle.

Bits 1:0 – SRC[1:0]: Recoverable Fault n Source

These bits select the TCC event input for recoverable Fault n.

Event system channel connected to MCEx event input, must be configured to route the event asynchronously, when used as a recoverable Fault n input.

Value	Name	Description
0x0	DISABLE	Fault input disabled
0x1	ENABLE	MCEx (x=0,1) event input



Value	Description
0	Overflow/underflow counter event is disabled and will not be generated.
1	Overflow/underflow counter event is enabled and will be generated for every counter overflow/underflow.

Bits 7:6 – CNTSEL[1:0]: Timer/Counter Interrupt and Event Output Selection

These bits define on which part of the counter cycle the counter event output is generated.

Value	Name	Description
0x0	BEGIN	An interrupt/event is generated at begin of each counter cycle
0x1	END	An interrupt/event is generated at end of each counter cycle
0x2	BETWEEN	An interrupt/event is generated between each counter cycle.
0x3	BOUNDARY	An interrupt/event is generated at begin of first counter cycle, and end of last counter cycle.

Bits 5:3 – EVACT1[2:0]: Timer/Counter Event Input 1 Action

These bits define the action the TCC will perform on TCE1 event input.

Value	Name	Description
0x0	OFF	Event action disabled.
0x1	RETRIGGER	Start restart or re-trigger TC on event
0x2	DIR (asynch)	Direction control
0x3	STOP	Stop TC on event
0x4	DEC	Decrement TC on event
0x5	PPW	Period captured into CC0 Pulse Width on CC1
0x6	PWP	Period captured into CC1 Pulse Width on CC0
0x7	FAULT	Non-recoverable Fault

Bits 2:0 – EVACT0[2:0]: Timer/Counter Event Input 0 Action

These bits define the action the TCC will perform on TCE0 event input 0.

Value	Name	Description
0x0	OFF	Event action disabled.
0x1	RETRIGGER	Start restart or re-trigger TC on event
0x2	COUNTEV	Count on event.
0x3	START	Start TC on event
0x4	INC	Increment TC on EVENT
0x5	COUNT (async)	Count on active state of asynchronous event
0x6	STAMP	Capture overflow times (Max value)
0x7	FAULT	Non-recoverable Fault



37.8.2. Event Control

Name:EVCTRLOffset:0x04Reset:0x00Property:PAC Write-Protection, Enable-Protected

Bit	7	6	5	4	3	2	1	0
								DATARDYEO
Access								R/W
Reset								0

Bit 0 – DATARDYEO: Data Ready Event Output

This bit indicates whether the Data Ready event output is enabled or not and an output event will be generated when a new random value is completed.

Value	Description
0	Data Ready event output is disabled and an event will not be generated.
1	Data Ready event output is enabled and an event will be generated.



Bits 3:2 – SPDCONF[1:0]: Speed Configuration

These bits select the speed configuration.

Value	Description
0x0	FS: Full-speed
0x1	LS: Low-speed
0x2	Reserved
0x3	Reserved

Bit 1 – UPRSM: Upstream Resume

This bit is cleared when the USB receives a USB reset or once the upstream resume has been sent.

Value	Description
0	Writing a zero to this bit has no effect.
1	Writing a one to this bit will generate an upstream resume to the host for a remote wakeup.

Bit 0 – DETACH: Detach

Value	Description
0	The device is attached to the USB bus so that communications may occur.
1	It is the default value at reset. The internal device pull-ups are disabled, removing the device from the USB bus.



41.3. Block Diagram

Figure 41-1. OPAMP Block Diagram



41.4. Signal Description

Signal	Description	Туре
OA0POS	OPAMP0 positive input	Analog input
OA0NEG	OPAMP0 negative input	Analog input
OA1POS	OPAMP1 positive input	Analog input

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42.8.14. Window Monitor Upper Threshold

Name:WINUTOffset:0x10Reset:0x0000Property:PAV Write-Protection, Write-Synchronized

Bit	15	14	13	12	11	10	9	8			
		WINUT[15:8]									
Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Reset	0	0	0	0	0	0	0	0			
Bit	7	6	5	4	3	2	1	0			
	WINUT[7:0]										
Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Reset	0	0	0	0	0	0	0	0			

Bits 15:0 – WINUT[15:0]: Window Upper Threshold

If the window monitor is enabled, these bits define the upper threshold value.



43.8.12. Comparator Control n

Name:COMPCTRLnOffset:0x10 + n*0x04 [n=0..1]Reset:0x00000000Property:PAC Write-Protection, Write-Synchronized

Bit	31	30	29	28	27	26	25	24	
			τυο	[1:0]			FLEN[2:0]		
Access			R/W	R/W		R/W	R/W	R/W	
Reset			0	0		0	0	0	
Bit	23	22	21	20	19	18	17	16	
			HYS	T[1:0]	HYSTEN		SPEE	SPEED[1:0]	
Access			R/W	R/W	R/W		R/W	R/W	
Reset			0	0	0		0	0	
Bit	15	14	13	12	11	10	9	8	
	SWAP		MUXPOS[2:0]				MUXNEG[2:0]		
Access	R/W	R/W	R/W	R/W		R/W	R/W	R/W	
Reset	0	0	0	0		0	0	0	
Bit	7	6	5	4	3	2	1	0	
		RUNSTDBY		INTS	EL[1:0]	SINGLE	ENABLE		
Access		R/W		R/W	R/W	R/W	R/W		
Reset		0		0	0	0	0		

Bits 29:28 - OUT[1:0]: Output

These bits configure the output selection for comparator n. COMPCTRLn.OUT can be written only while COMPCTRLn.ENABLE is zero.

Note: For internal use of the comparison results by the CCL, this bit must be 0x1 or 0x2.

These bits are not synchronized.

Value	Name	Description
0x0	OFF	The output of COMPn is not routed to the COMPn I/O port
0x1	ASYNC	The asynchronous output of COMPn is routed to the COMPn I/O port
0x2	SYNC	The synchronous output (including filtering) of COMPn is routed to the COMPn I/O port
0x3	N/A	Reserved

Bits 26:24 – FLEN[2:0]: Filter Length

These bits configure the filtering for comparator n. COMPCTRLn.FLEN can only be written while COMPCTRLn.ENABLE is zero.

These bits are not synchronized.



1. These values are based on simulation. They are not covered by production test limits or characterization.

46.10.1.2. LDO Regulator

Table 46-16. LDO Regulator Electrical Characteristics

Symbol	Parameter	Conditions	Тур.	Units
VREGSCAL	Voltage scaling	min step size for PLx to Ply transistion	5	mV
		Voltage Scaling Period ⁽¹⁾	1	μs

Note: 1. These are based on simulation. These values are not covered by test or characterization

Table 46-17. External Components Requirements in Linear Mode

Symbol	Parameter	Conditions	Тур.	Units
C _{IN}	Input regulator capacitor		4.7	μF
		Ceramic dielectric X7R	100	nF
C _{OUT}	Output regulator capacitor		1	μF
		Ceramic dielectric X7R	100	nF

46.10.2. APWS

Table 46-18. Automatic Power Switch Characteristics

Symbol	Parameters	Min.	Тур.	Max.	Unit
CD	Decoupling capacitor on VDDIN	-	4.7	-	μF
T _{HUP}	V _{DDIN} threshold	-	1.84	-	V
T _{HDWN}		-	1.75	-	V
T _{HHYS}	V _{DDIN} hysteresis	-	90	-	mV

Note: With CDmin = Imax /(dV/dt)

46.10.3. Power-On Reset (POR) Characteristics

Table 46-19. POR33 Characteristics

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Unit
V _{POT+}	Voltage threshold Level on V_{DDIN} rising		1.53	1.58	1.62	V
V _{POT-}	Voltage threshold Level on V _{DDIN} falling		0.6	1.04	1.39	V



Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
Ret _{EE100k}	Retention after up to 100k	Average ambient 55°C	10	50	-	Years
Ret _{EE10k}	Retention after up to 10k	Average ambient 55°C	20	100	-	Years
Cyc _{EE}	Cycling Endurance ⁽²⁾	-40°C < Ta < 85°C	100K	400K	-	Cycles

Note:

(1) The EEPROM emulation is a software emulation described in the App note AT03265.

(2) An endurance cycle is a write and an erase operation.

Table 46-43. Flash Erase and Programming Current

Symbol	Parameter	Тур.	Units
IDD _{NVM}	Maximum current (peak) during whole programming or erase operation	10	mA

46.12. Oscillators Characteristics

46.12.1. Crystal Oscillator (XOSC) Characteristics

Digital Clock Characteristics

The following table describes the characteristics for the oscillator when a digital clock is applied on XIN. Table 46-44. Digital Clock Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units
F _{XIN}	XIN clock frequency	-	-	24	MHz
DC _{XIN}	XIN clock duty cycle	40	50	60	%

Chrystal Oscillator Characteristics

The following Table describes the characteristics for the oscillator when a crystal is connected between XIN and XOUT.

Figure 46-3. Oscillator Connection





		Wait for INTFLAG.EMPTY to be one after enabling the DAC instead of waiting for STATUS.READY.
		2 – If CLK_APB_DAC is slower than GCLK_DAC the STATUS.READY bit may never be set. Errata reference: 14664 Fix/Workaround: Wait for INTELAG EMPTY to be one after enabling the DAC instead of
		waiting for STATUS.READY.
		 3 - For specific DAC configurations, the SYNCBUSY.DATA1 and SYNCBUSY.DATABUF1 may be stuck at 1. Errata reference: 14910 Fix/Workaround: Don't use the Refresh mode and Events at the same time for DAC1. If event is used, write data to DATABUF1 with no refresh. DAC0 is not limited by this restriction
		 4 – The SYNCBUSY.ENABLE bit is stuck at 1 after disabling and enabling the DAC when refresh is used. Errata reference: 14885 Fix/Workaround: After the DAC is disabled in refresh mode, wait for at least 30us before reenabling the DAC.
50.2.5.	TRNG	
		 1 – When TRNG is enabled with configuration CTRL.RUNSTDBY = 0, (disabled during sleep) it could still continue to operate resulting in over-consumption (~50uA) in standby mode. Errata reference: 14827 Fix/Workaround: Disable the TRNG before entering standby mode.
50.2.6.	ADC	
		1 – Overconsumption for up to 1.6 seconds on VDDANA when the ADC is disabled(manually or automatically) Errata reference: 14349 Fix/Workaround : None
		2 – The ADC Effective number of Bits (ENOB) is 9.2 in this revision
50.2.7.	DFLL48M	
		 1 – The DFLL clock must be requested before being configured otherwise a write access to a DFLL register can freeze the device. Errata reference: 9905 Fix/Workaround: Write a zero to the DFLL ONDEMAND bit in the DFLLCTRL register before configuring the DFLL module.
		2 – If the DFLL48M reaches the maximum or minimum COARSE or FINE calibration values during the locking sequence, an out of bounds interrupt will be generated. These interrupts will be generated even if

